


<b>Search Notes</b> 	<b>Application/Control No.</b> 10520787	<b>Applicant(s)/Patent Under Reexamination</b> MIYOSHI ET AL.
	<b>Examiner</b> Miah, Liton	<b>Art Unit</b> 2617

SEARCHED			
Class	Subclass	Date	Examiner
370	329	9/25/2007	Liton Miah
370	331	9/25/2007	Liton Miah
370	235	9/25/2007	Liton Miah
714	707	9/25/2007	Liton Miah
714	708	9/25/2007	Liton Miah
714	704	9/25/2007	Liton Miah

SEARCH NOTES		
Search Notes	Date	Examiner
EAST (US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB)	9/25/2007	Liton Miah
Consulted with Spe (Rafael Gutierrez-Perez)	9/25/2007	Liton Miah
Inventorship Search	9/25/2007	Liton Miah

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner